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SEMICONDUCTOR

## 74F2244 **Octal Buffer/Line Driver** with 25 $\Omega$ Series Resistors in Outputs

#### **General Description**

The F2244 is an octal buffer/line driver designed to drive the capacitive inputs of MOS memory drivers, address drivers, clock drivers and bus-oriented transmitters/receivers.

The  $25\Omega$  series resistors in the outputs reduce ringing and eliminate the need for external resistors.

#### **Features**

■ 3-STATE outputs drive bus lines or buffer memory address registers

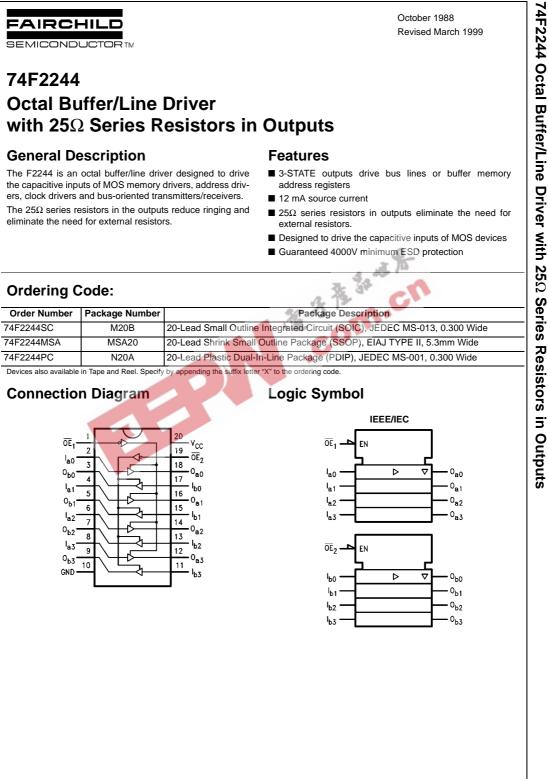
October 1988

Revised March 1999

- 12 mA source current
- **\blacksquare** 25 $\Omega$  series resistors in outputs eliminate the need for
- external resistors.
- Designed to drive the capacitive inputs of MOS devices
- Guaranteed 4000V minimum ESD protection

#### **Ordering Code:**

Order Number	Package Number	Package Description
74F2244SC	M20B	20-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-013, 0.300 Wide
74F2244MSA	MSA20	20-Lead Shrink Small Outline Package (SSOP), EIAJ TYPE II, 5.3mm Wide
74F2244PC	N20A	20-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide
Devices also evoilable	in Tono and Bool Specifi	(by appending the suffix letter "V" to the ordering code



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## **Unit Loading/Fan Out**

	Pin Names	Description	U.L.	Input I <sub>IH</sub> /I <sub>IL</sub>
			HIGH/LOW	Output I <sub>OH</sub> /I <sub>OL</sub>
	$\overline{OE}_1, \overline{OE}_2$	3-STATE Output Enable Input (Active LOW)	1.0/1.667	20 µA/–1 mA
	OE <sub>2</sub>	3-STATE Output Enable Input (Active HIGH)	1.0/1.667	20 µA/–1 mA
	I <sub>an</sub> , I <sub>bn</sub>	Inputs	1.0/2.667 (Note 1)	20 µA/–1.6 mA
	O <sub>an</sub> ,O <sub>bn</sub>	Outputs	750/20	–15 mA/12 mA
te 1: Worst-	case F2244 disat	led		

#### **Truth Table**

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OE <sub>1</sub>	l <sub>an</sub>	O <sub>an</sub>	OE <sub>2</sub>	I <sub>bn</sub>	O <sub>bn</sub>
н	х	Z	Н	х	Z
L	н	н	L	н	н
L	L	L	L	L	L
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X = Immaterial Z = High Impedance

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#### Absolute Maximum Ratings(Note 2)

	-
Storage Temperature	-65°C to +150°C
Ambient Temperature under Bias	$-55^{\circ}C$ to $+125^{\circ}C$
Junction Temperature under Bias	$-55^{\circ}C$ to $+150^{\circ}C$
V <sub>CC</sub> Pin Potential to Ground Pin	-0.5V to +7.0V
Input Voltage (Note 3)	-0.5V to +7.0V
Input Current (Note 3)	-30 mA to +5.0 mA
Voltage Applied to Output	
in HIGH State (with $V_{CC} = 0V$ )	
Standard Output	-0.5V to V <sub>CC</sub>
3-STATE Output	-0.5V to +5.5V
Current Applied to Output	
in LOW State (Max)	twice the rated $I_{OL}\ (mA)$
ESD Last Passing Voltage (Min)	4000V
	Ambient Temperature under Bias Junction Temperature under Bias $V_{CC}$ Pin Potential to Ground Pin Input Voltage (Note 3) Input Current (Note 3) Voltage Applied to Output in HIGH State (with $V_{CC} = 0V$ ) Standard Output 3-STATE Output Current Applied to Output in LOW State (Max)

# Recommended Operating Conditions

Free Air Ambient Temperature	
Supply Voltage	

74F2244

0°C to +70°C +4.5V to +5.5V

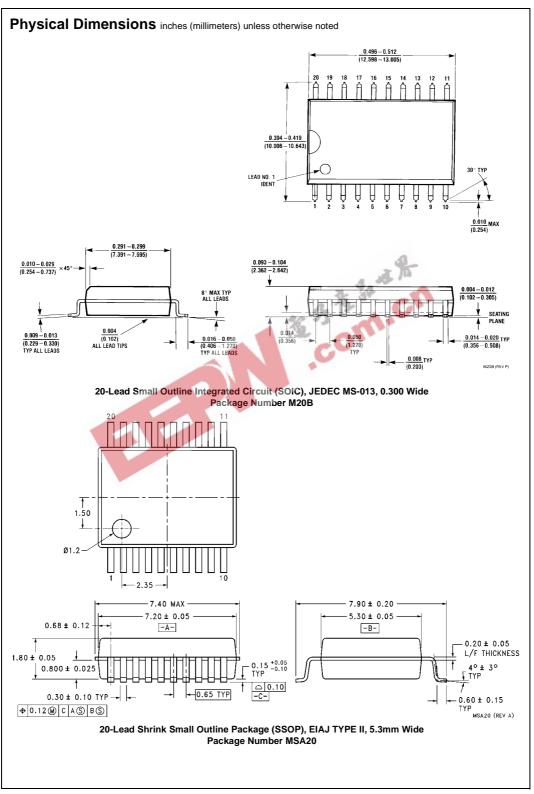
Note 2: Absolute maximum ratings are values beyond which the device may be damaged or have its useful life impaired. Functional operation under these conditions is not implied.

Note 3: Either voltage limit or current limit is sufficient to protect inputs.

## **DC Electrical Characteristics**

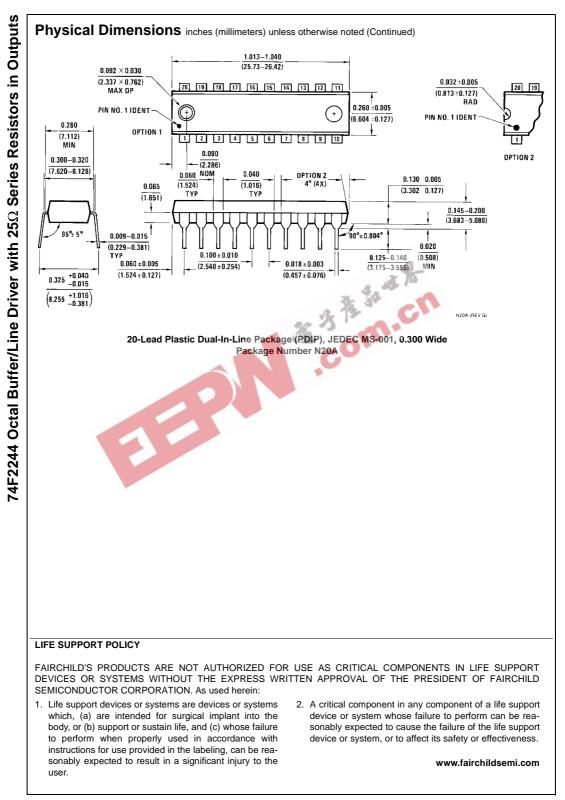
Symbol	Parameter	Min	Тур	Max	Units	V <sub>CC</sub>	Conditions
VIH	Input HIGH Voltage	2.0			V	-	Recognized as a HIGH Signal
VIL	Input LOW Voltage			0.8	V		Recognized as a LOW Signal
V <sub>CD</sub>	Input Clamp Diode Voltage			-1.2	V	Min	I <sub>IN</sub> = -18 mA
V <sub>OH</sub>	Output HIGH Voltage 10% V <sub>CC</sub>	2.4		132	V	Min	I <sub>OH</sub> = -3 mA
	10% V <sub>CC</sub>	2.0			0		I <sub>OH</sub> = -15 mA
	5% V <sub>CC</sub>	2.7					$I_{OH} = -3 \text{ mA}$
V <sub>OL</sub>	Output LOW Voltage			0.50	V	Min	I <sub>OL</sub> = 1 mA
				0.75			$I_{OL} = 12 \text{ mA}$
IIH	Input HIGH Current			5.0	μA	Max	V <sub>IN</sub> = 2.7V
I <sub>BVI</sub>	Input HIGH Current Breakdown Test			7.0	μA	Max	V <sub>IN</sub> = 7.0V
ICEX	Output HIGH Leakage Current		-	50	μA	Max	$V_{OUT} = V_{CC}$
V <sub>ID</sub>	Input Leakage	4.75			V	0.0	$I_{ID} = 1.9 \ \mu A$
	Test						All other pins grounded
I <sub>OD</sub>	Output Leakage			3.75	μA	0.0	V <sub>IOD</sub> = 150 mV
	Circuit Current						All other pins grounded
IIL	Input LOW Current			-1.0	mA	Max	$V_{IN} = 0.5V (\overline{OE}_1, \overline{OE}_2, OE_2)$
				-1.6			$V_{IN} = 0.5V (I_n)$
I <sub>OZH</sub>	Output Leakage Current			50	μA	Max	V <sub>OUT</sub> = 2.7V
I <sub>OZL</sub>	Output Leakage Current			-50	μA	Max	$V_{OUT} = 0.5V$
los	Output Short-Circuit Current	-100		-225	mA	Max	$V_{OUT} = 0V$
ICCH	Power Supply Current		40	60	mA	Max	V <sub>O</sub> = HIGH
I <sub>CCL</sub>	Power Supply Current		60	90	mA	Max	$V_0 = LOW$
I <sub>CCZ</sub>	Power Supply Current		60	90	mA	Max	$V_{\Omega} = HIGH Z$

			T <sub>A</sub> = +25°C	$T_{A} = -55^{\circ}$	5 to +125°C	$T_A = 0^{\circ}C$	10 +70 C	
			$V_{CC} = +5.0V$	<b>C</b> <sub>1</sub> =	50 pF	<b>C</b> <sub>1</sub> =	50 pF	
Symbol	Parameter		C <sub>L</sub> = 50 pF	-		-		Units
		Min	Тур Мах	Min	Max	Min	Max	
t <sub>PLH</sub>	Propagation Delay	1.5	7.0	2.0	6.5	1.5	7.0	ns
t <sub>PHL</sub>	Data to Output	2.5	8.0	2.0	7.0	2.0	8.0	
t <sub>PZH</sub>	Output Enable Time	1.5	9.0	2.0	7.0	1.0	9.5	
t <sub>PZL</sub>		2.5	11.5	2.0	8.5	2.5	12.0	ns
t <sub>PHZ</sub>	Output Disable Time	1.5	9.0	2.0	7.0	1.0	9.5	
t <sub>PLZ</sub>		1.5	8.5	2.0	7.5	1.5	9.5	
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